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# BUK9Y14-80E

N-channel 80 V, 15 mΩ logic level MOSFET in LFPAK56

11 November 2014

Product data sheet

## 1. General description

Logic level N-channel MOSFET in an LFPAK56 (Power SO8) package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

## 2. Features and benefits

- Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True logic level gate with  $V_{GS(th)}$  rating of greater than 0.5 V at 175 °C

## 3. Applications

- 12 V, 24 V and 48 V Automotive systems
- Motors, lamps and solenoid control
- Transmission control
- Ultra high performance power switching

## 4. Quick reference data

**Table 1. Quick reference data**

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \geq 25^\circ\text{C}$ ; $T_j \leq 175^\circ\text{C}$		-	-	80	V
$I_D$	drain current	$V_{GS} = 5\text{ V}$ ; $T_{mb} = 25^\circ\text{C}$ ; <a href="#">Fig. 1</a>		-	-	62	A
$P_{tot}$	total power dissipation	$T_{mb} = 25^\circ\text{C}$ ; <a href="#">Fig. 2</a>		-	-	147	W
<b>Static characteristics</b>							
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 5\text{ V}$ ; $I_D = 15\text{ A}$ ; $T_j = 25^\circ\text{C}$ ; <a href="#">Fig. 11</a>		-	12.2	15	$\text{m}\Omega$
<b>Dynamic characteristics</b>							
$Q_{GD}$	gate-drain charge	$V_{GS} = 5\text{ V}$ ; $I_D = 15\text{ A}$ ; $V_{DS} = 64\text{ V}$ ; $T_j = 25^\circ\text{C}$ ; <a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a>		-	8.7	-	nC



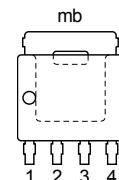
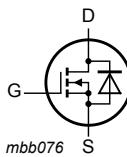
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### 5. Pinning information

**Table 2. Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		
2	S	source		
3	S	source		
4	G	gate		
mb	D	mounting base; connected to drain		

LFPAK56; Power-SO8 (SOT669)

### 6. Ordering information

**Table 3. Ordering information**

Type number	Package			Version
	Name	Description		
BUK9Y14-80E	LFPAK56; Power-SO8	Plastic single-ended surface-mounted package (LFPAK56; Power-SO8); 4 leads		SOT669

### 7. Marking

**Table 4. Marking codes**

Type number	Marking code
BUK9Y14-80E	91480E

### 8. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \geq 25^\circ\text{C}$ ; $T_j \leq 175^\circ\text{C}$	-	80	V
$V_{DGR}$	drain-gate voltage	$R_{GS} = 20\text{ k}\Omega$	-	80	V
$V_{GS}$	gate-source voltage	$T_j \leq 175^\circ\text{C}$ ; DC	-10	10	V
		$T_j \leq 175^\circ\text{C}$ ; Pulsed	[1][2]	-15	V
$P_{tot}$	total power dissipation	$T_{mb} = 25^\circ\text{C}$ ; <a href="#">Fig. 2</a>	-	147	W
$I_D$	drain current	$T_{mb} = 25^\circ\text{C}$ ; $V_{GS} = 5\text{ V}$ ; <a href="#">Fig. 1</a>	-	62	A
		$T_{mb} = 100^\circ\text{C}$ ; $V_{GS} = 5\text{ V}$ ; <a href="#">Fig. 1</a>	-	44	A
$I_{DM}$	peak drain current	$T_{mb} = 25^\circ\text{C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; <a href="#">Fig. 4</a>	-	250	A

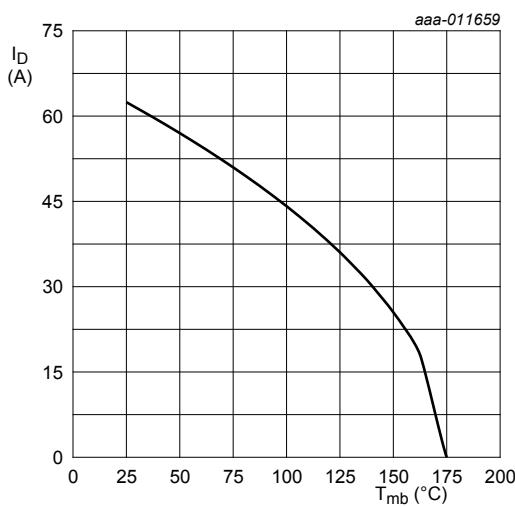
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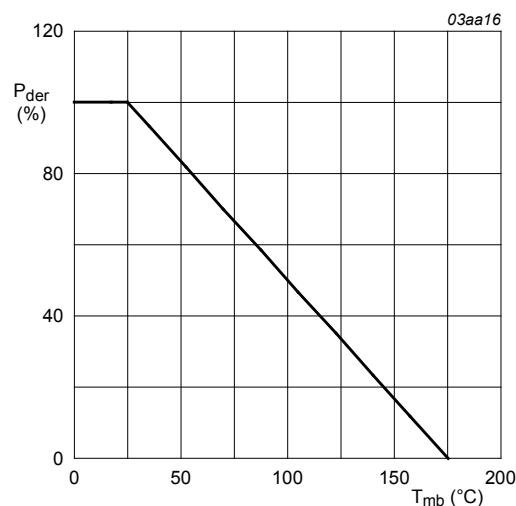
Symbol	Parameter	Conditions		Min	Max	Unit
T <sub>stg</sub>	storage temperature			-55	175	°C
T <sub>j</sub>	junction temperature			-55	175	°C
<b>Source-drain diode</b>						
I <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C		-	62	A
I <sub>SM</sub>	peak source current	pulsed; t <sub>p</sub> ≤ 10 µs; T <sub>mb</sub> = 25 °C		-	250	A
<b>Avalanche ruggedness</b>						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	I <sub>D</sub> = 62 A; V <sub>sup</sub> ≤ 80 V; R <sub>GS</sub> = 50 Ω; V <sub>GS</sub> = 5 V; T <sub>j(init)</sub> = 25 °C; unclamped; <a href="#">Fig. 3</a>	[3][4]	-	79.6	mJ

- [1] Accumulated pulse duration up to 50 hours delivers zero defect ppm
- [2] Significantly longer life times are achieved by lowering T<sub>j</sub> and or V<sub>GS</sub>
- [3] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [4] Refer to application note AN10273 for further information.



**Fig. 1. Continuous drain current as a function of mounting base temperature**

V<sub>GS</sub> ≥ 5V



**Fig. 2. Normalized total power dissipation as a function of mounting base temperature**

$$P_{der} = \frac{P_{tot}}{P_{tot}(25^\circ C)} \times 100 \%$$

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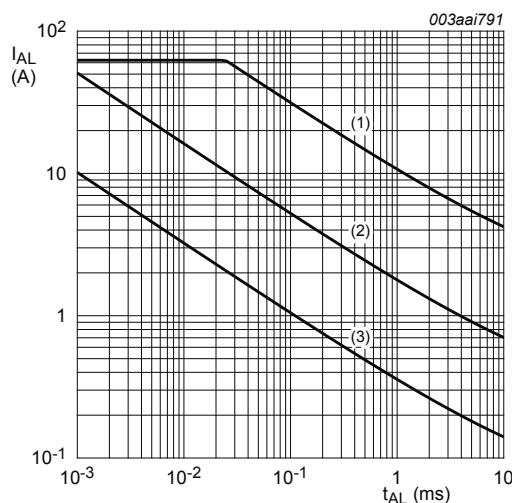


Fig. 3. Avalanche rating; avalanche current as a function of avalanche time

(1)  $T_j (int) = 25^\circ C$ ; (2)  $T_j (int) = 150^\circ C$ ; (3) Repetitive Avalanche

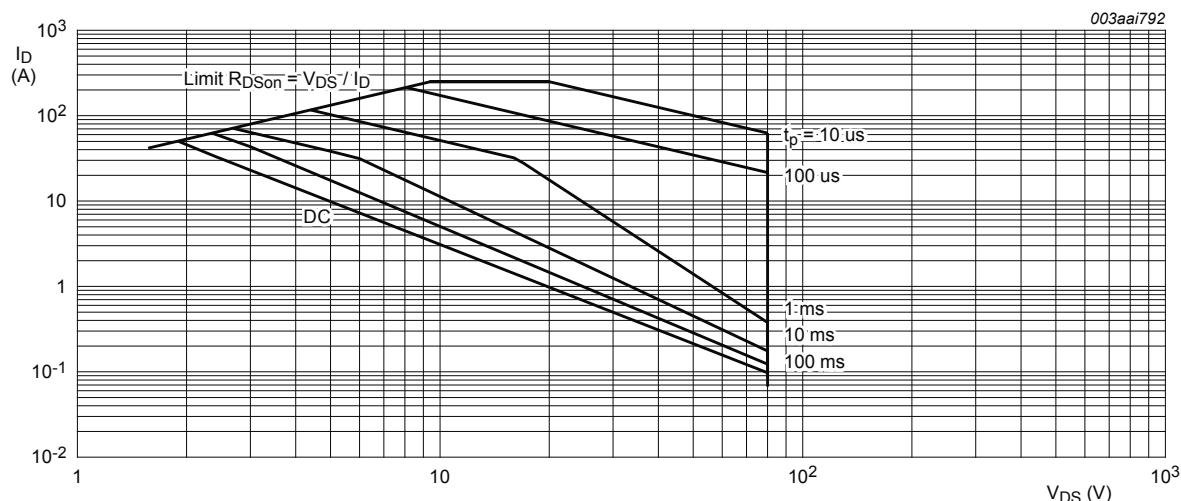


Fig. 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

$T_{mb} = 25^\circ C$ ;  $I_{DM}$  is a single pulse

## 9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	<a href="#">Fig. 5</a>	-	-	1.02	K/W

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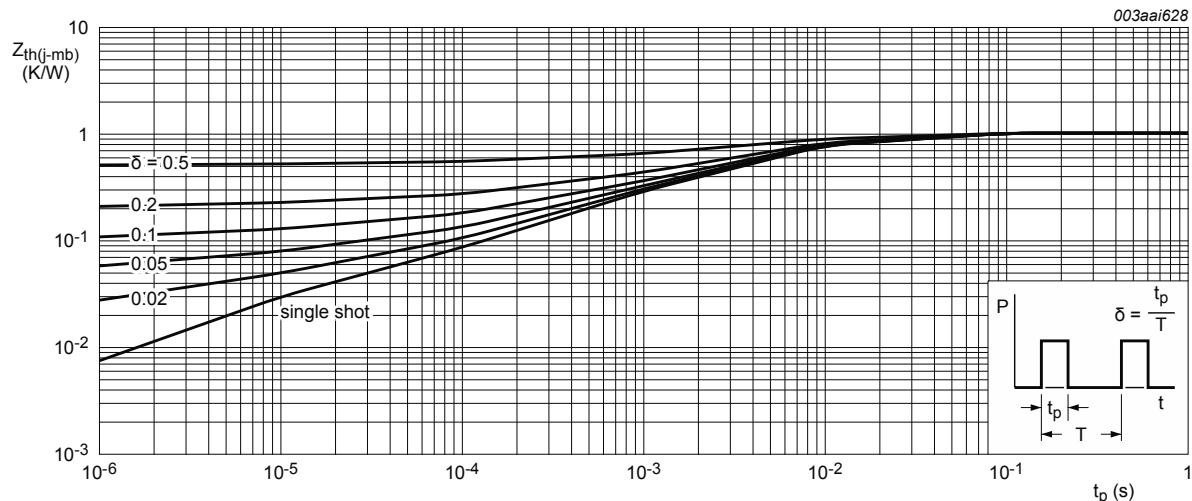


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 10. Characteristics

Table 7. Characteristics

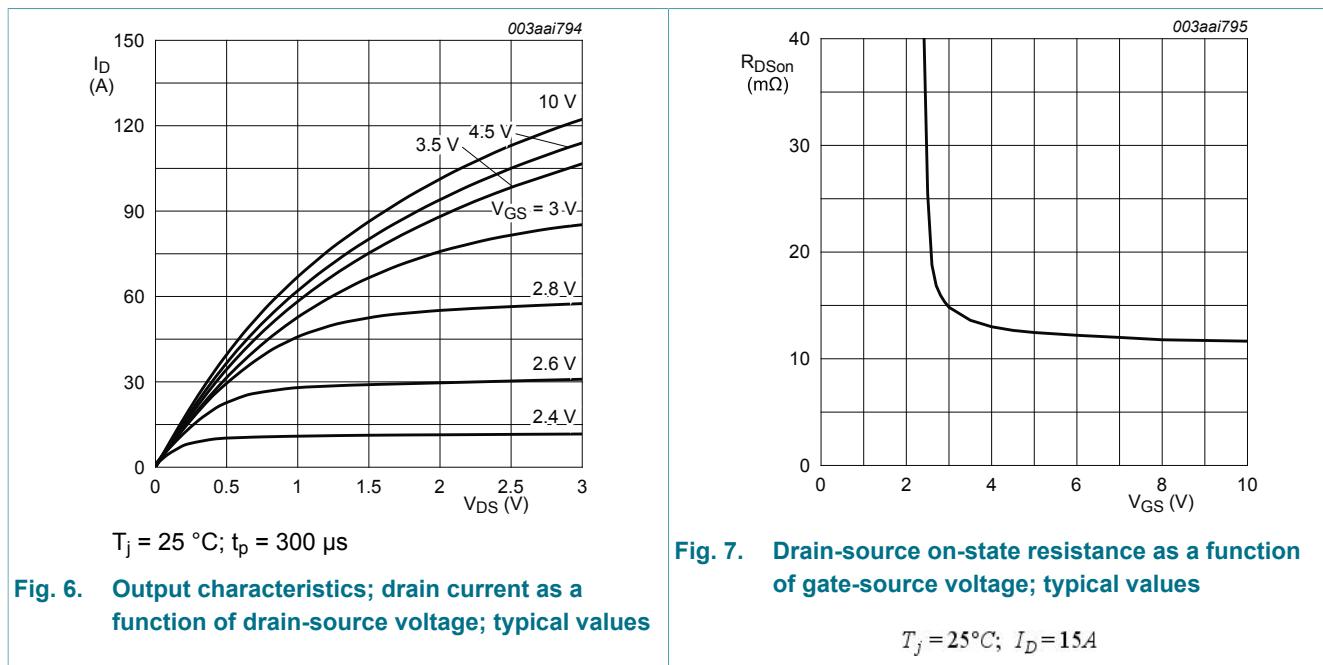
Symbol	Parameter	Conditions		Min	Typ	Max	Unit
<b>Static characteristics</b>							
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25^\circ C$		80	-	-	V
		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55^\circ C$		72	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 mA; V_{DS} = V_{GS}; T_j = 25^\circ C;$ <a href="#">Fig. 9</a> ; <a href="#">Fig. 10</a>		1.4	1.7	2.1	V
		$I_D = 1 mA; V_{DS} = V_{GS}; T_j = -55^\circ C;$ <a href="#">Fig. 9</a>		-	-	2.45	V
		$I_D = 1 mA; V_{DS} = V_{GS}; T_j = 175^\circ C;$ <a href="#">Fig. 9</a>		0.5	-	-	V
$I_{DSS}$	drain leakage current	$V_{DS} = 80 V; V_{GS} = 0 V; T_j = 25^\circ C$		-	0.25	10	$\mu A$
$I_{DSS}$	drain leakage current	$V_{DS} = 80 V; V_{GS} = 0 V; T_j = 175^\circ C$		-	-	500	$\mu A$
$I_{GSS}$	gate leakage current	$V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25^\circ C$		-	2	100	nA
		$V_{GS} = -10 V; V_{DS} = 0 V; T_j = 25^\circ C$		-	2	100	nA
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 5 V; I_D = 15 A; T_j = 25^\circ C;$ <a href="#">Fig. 11</a>		-	12.2	15	$m\Omega$
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 10 V; I_D = 15 A; T_j = 25^\circ C;$ <a href="#">Fig. 11</a>		-	11.3	14	$m\Omega$
		$V_{GS} = 5 V; I_D = 15 A; T_j = 175^\circ C;$ <a href="#">Fig. 11</a> ; <a href="#">Fig. 12</a>		-	-	37.65	$m\Omega$

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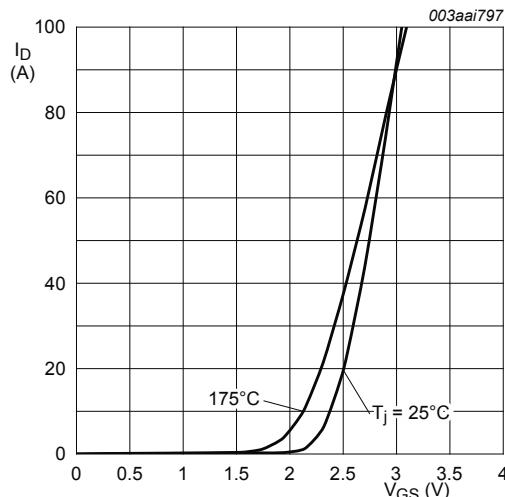
Symbol	Parameter	Conditions		Min	Typ	Max	Unit
<b>Dynamic characteristics</b>							
$Q_{G(\text{tot})}$	total gate charge	$I_D = 15 \text{ A}$ ; $V_{DS} = 64 \text{ V}$ ; $V_{GS} = 5 \text{ V}$ ; $T_j = 25^\circ\text{C}$ ; <a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a>		-	28.9	-	nC
$Q_{GS}$	gate-source charge			-	8.1	-	nC
$Q_{GD}$	gate-drain charge			-	8.7	-	nC
$C_{iss}$	input capacitance	$V_{GS} = 0 \text{ V}$ ; $V_{DS} = 25 \text{ V}$ ; $f = 1 \text{ MHz}$ ;		-	3479	4640	pF
$C_{oss}$	output capacitance	$T_j = 25^\circ\text{C}$ ; <a href="#">Fig. 15</a>		-	236	283	pF
$C_{rss}$	reverse transfer capacitance			-	114	156	pF
$t_{d(\text{on})}$	turn-on delay time	$V_{DS} = 60 \text{ V}$ ; $R_L = 4 \Omega$ ; $V_{GS} = 5 \text{ V}$ ;		-	15.3	-	ns
$t_r$	rise time	$R_{G(\text{ext})} = 5 \Omega$ ; $T_j = 25^\circ\text{C}$		-	24.6	-	ns
$t_{d(\text{off})}$	turn-off delay time			-	45.3	-	ns
$t_f$	fall time			-	24.7	-	ns
<b>Source-drain diode</b>							
$V_{SD}$	source-drain voltage	$I_S = 15 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25^\circ\text{C}$ ; <a href="#">Fig. 16</a>		-	0.8	1.2	V
$t_{rr}$	reverse recovery time	$I_S = 20 \text{ A}$ ; $dI_S/dt = -100 \text{ A}/\mu\text{s}$ ; $V_{GS} = 0 \text{ V}$ ;		-	25.8	-	ns
$Q_r$	recovered charge	$V_{DS} = 25 \text{ V}$ ; $T_j = 25^\circ\text{C}$		-	29.3	-	nC



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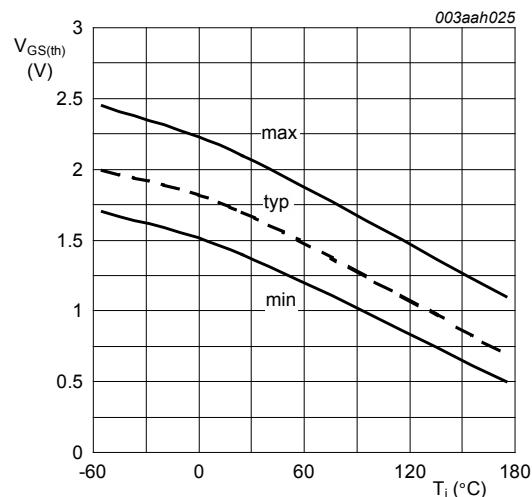
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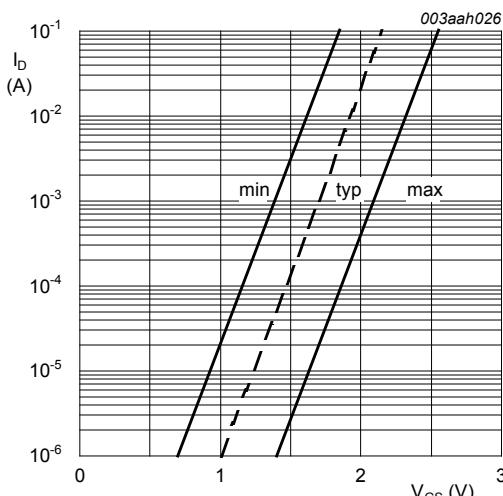
**Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values**

$V_{DS} = 10V$



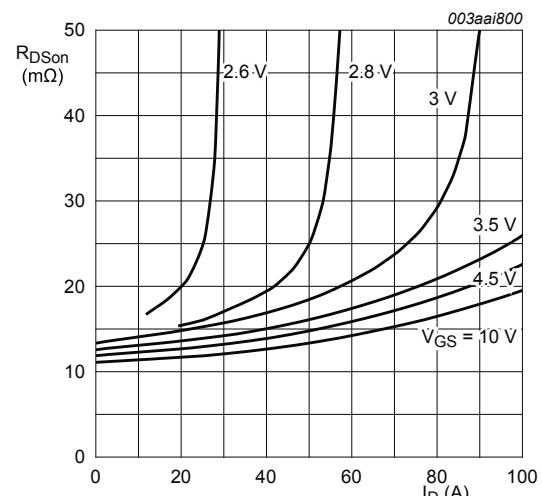
**Fig. 9. Gate-source threshold voltage as a function of junction temperature**

$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$



**Fig. 10. Sub-threshold drain current as a function of gate-source voltage**

$T_j = 25^\circ\text{C}; V_{DS} = 5V$



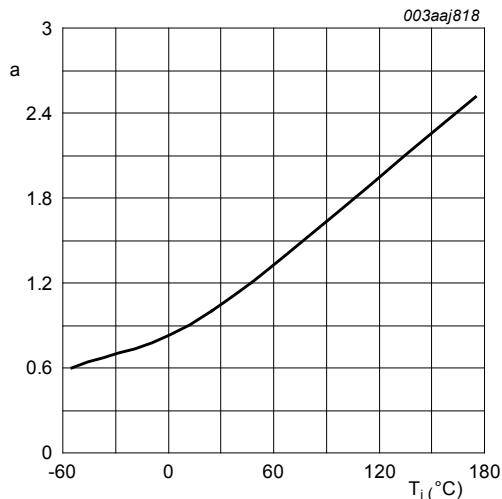
$T_j = 25^\circ\text{C}; t_p = 300 \mu\text{s}$

**Fig. 11. Drain-source on-state resistance as a function of drain current; typical values**

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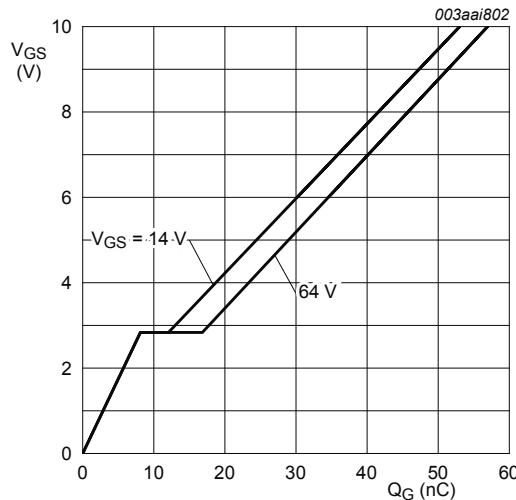
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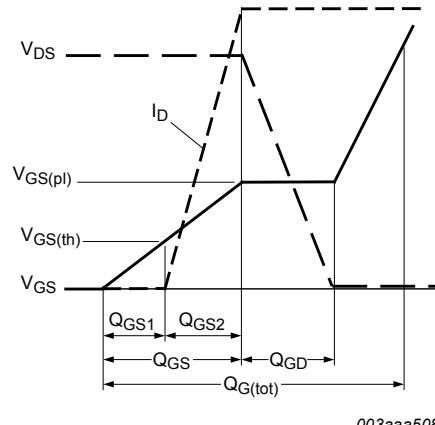
**Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature**

$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ C)}$$

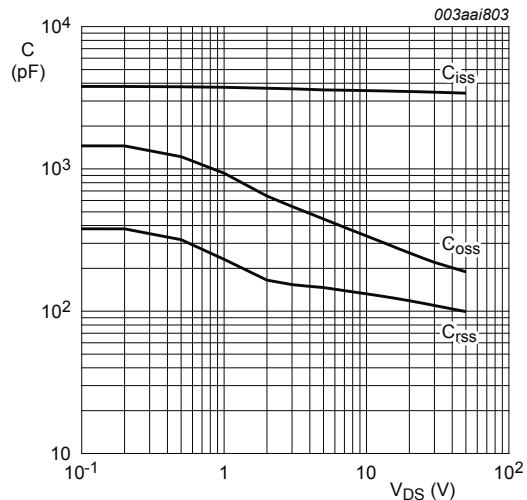


**Fig. 14. Gate-source voltage as a function of gate charge; typical values**

$$T_j = 25^\circ C; I_D = 15A$$

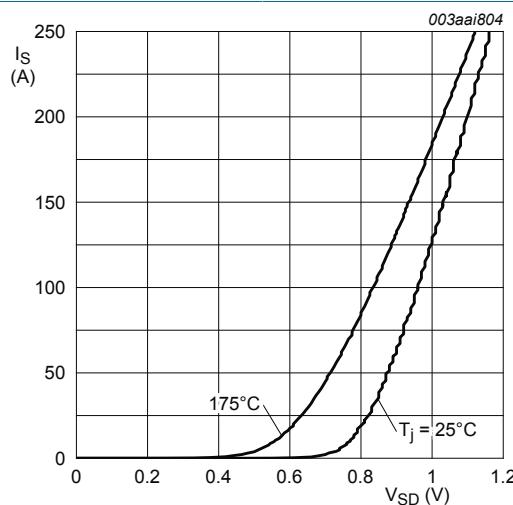


**Fig. 13. Gate charge waveform definitions**



**Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**

$$V_{GS} = 0V; f = 1MHz$$

**NXP Semiconductors****BUK9Y14-80E****N-channel 80 V,15 mΩ logic level MOSFET in LFPAK56****Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values**

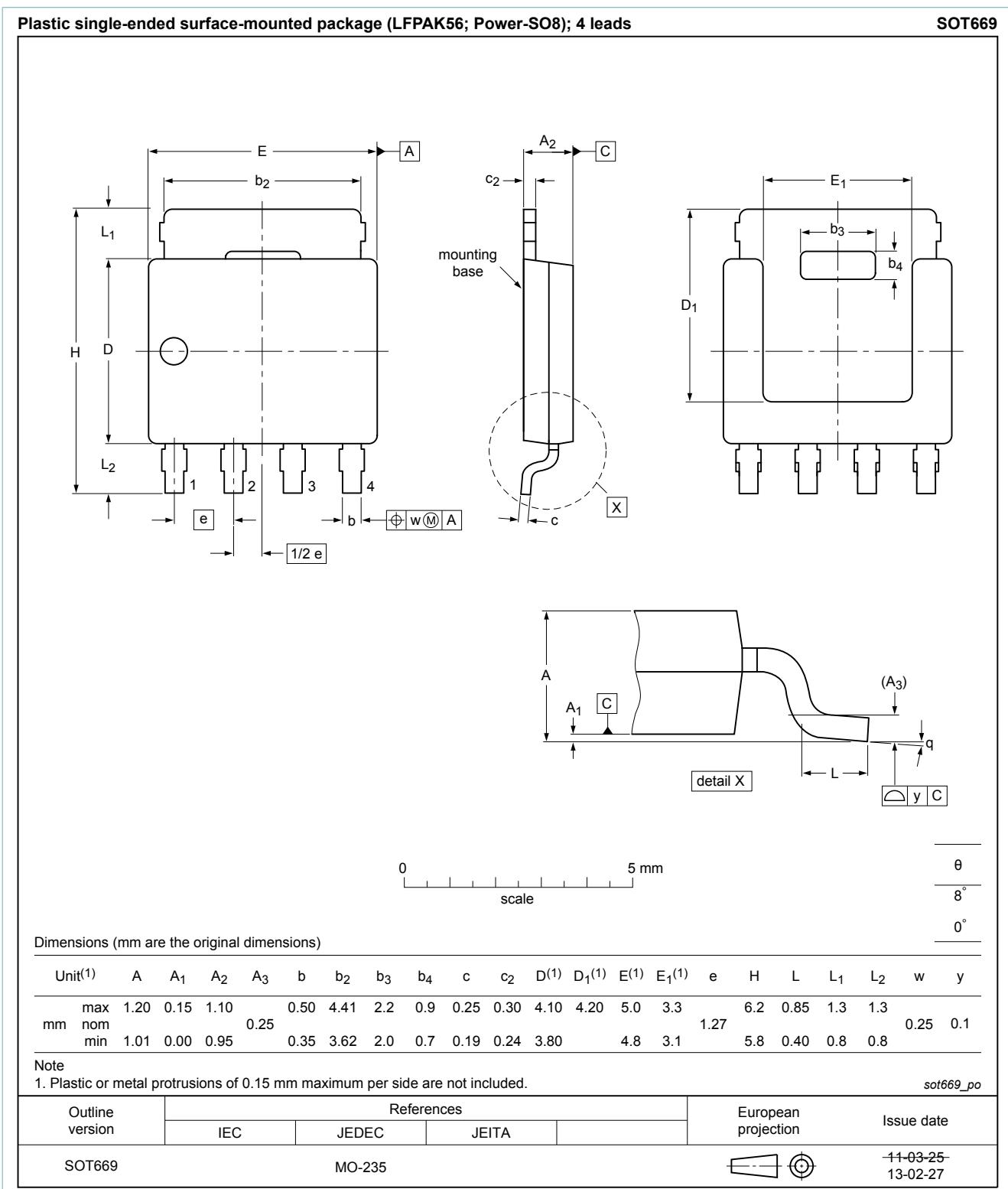
$$V_{GS} = 0V$$

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### 11. Package outline



**Fig. 17. Package outline LFPAK56; Power-SO8 (SOT669)**

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### N-channel 80 V,15 mΩ logic level MOSFET in LFPAK56

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Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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